

# M2114A 1024 X 4 BIT STATIC RAM

### **MILITARY**

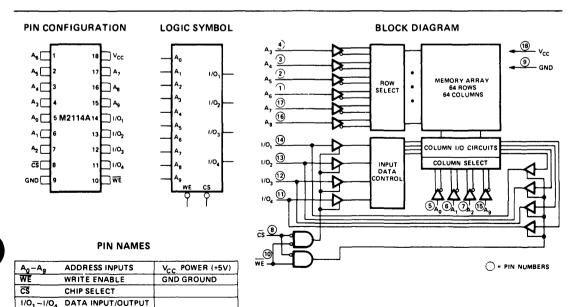
	M2114AL-3	M2114AL-4	M2114A-4	M2114A-5
Max. Access Time (ns)	150	200	200	250 ·
Max. Current (mA)	50	50	70	70

- HMOS Technology
- Low Power, High Speed
- Identical Cycle and Access Times
- Single +5V Supply ±10%
- High Density 18 Pin Package
- Completely Static Memory No Clock or Timing Strobe Required
- Directly TTL Compatible: All Inputs and Outputs
- Common Data Input and Output Using Three-State Outputs
- M2114 Upgrade
- Military Temperature Range -55°C to +125°C

The Intel\* M2114A is a 4096-bit static Random Access Memory organized as 1024 words by 4-bits using HMOS a high performance MOS technology. It uses fully DC stable (static) circuitry throughout in both the array and the decoding therefore it requires no clocks or refreshing to operate. Data access is particularly simple since address setup times are not required. The data is read out nondestructively and has the same polarity as the input data. Common input/output pins are provided.

The M2114A is designed for memory applications where the high performance and high reliability of HMOS low cost large bit storage and simple interfacing are important design objectives. The M2114A is placed in an 18-pin package for the highest possible density.

It is directly TTL compatible in all respects inputs outputs and a single 15V supply. A separate Chip Select (CS) lead allows easy selection of an individual package when outputs are or-tied





#### **ABSOLUTE MAXIMUM RATINGS\***

Temperature Under Bias -65° C to 135° C Storage Temperature -65° C to 150° C

Voltage on any Pin

With Respect to Ground -3 5V to +7V
Power Dissipation 1 0W
D C Output Current 5mA

\*COMMENT Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

### D.C. AND OPERATING CHARACTERISTICS

 $T_A = -55$ °C to  $\pm 125$ °C  $V_{CC} = 5V \pm 10\%$  unless otherwise noted

SYMBOL	PARAMETER	M2 Min	114AL-3. Typ <sup>1</sup>	/L-4 Max	Mın	12114A-4/ Typ <sup>11</sup>	/-5 Max	UNIT	CONDITIONS
14	Input Load Current (All Input Pins)			10			10	μΑ	V <sub>IN</sub> = 0 to 5 5V
الدها	I/O Leakage Current			10			10	μΑ	$\overline{CS} = V_{IH}$ $V_{I/O} - GND \text{ to } V_{CC}$
Icc	Power Supply Current		25	50		50	70	mA	$V_{CC} = max I_{1/O} = 0 mA$ $T_A = -55^{\circ}C$
VıL	Input Low Voltage	-30		0 8	-3 0		0 8	V	
ViH	Input High Voltage	20		60	20		60	V	
IoL	Output Low Current	2 1	9 0		2 1	9 0		mA	V <sub>OL</sub> = 0 4V
Іон	Output High Current	-10	-2 5		-10	-2 5		mA	V <sub>OH</sub> = 2 4V
l <sub>OS(2)</sub>	Output Short Circuit Current			40			40	mA	V <sub>OUT</sub> = GND

NOTE 1 Typical values are for  $T_A = 25^{\circ}C$  and  $V_{CC} = 5.0V$ 

# CAPACITANCE

 $T_A = 25$ °C f = 10 MHz

SYMBOL	TEST	MAX	UNIT	CONDITIONS
C <sub>1/0</sub>	Input/Output Capacitance	5	pF	V <sub>NO</sub> = 0V
Cin	Input Capacitance	5	pF	V <sub>IN</sub> = 0V

NOTE This parameter is periodically sampled and not 100% tested

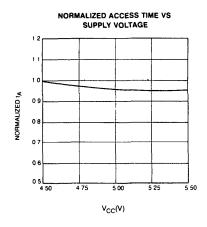
## A.C. CONDITIONS OF TEST

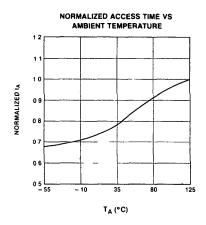
Input Pulse Levels 0 8 Volt to 2 0 Volt Input Rise and Fall Times 10 nsec Input and Output Timing Levels 1 5 Volts Output Load 1 TTL Gate and  $C_L = 100 \ pF$ 

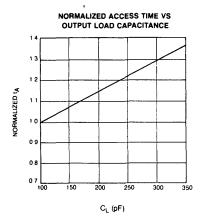
<sup>2</sup> Duration not to exceed 30 seconds

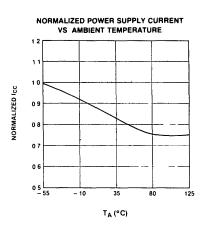
# ألطint

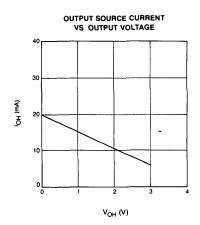
# TYPICAL D.C. AND A.C. CHARACTERISTICS

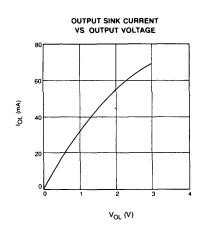














# **A.C. CHARACTERISTICS** $T_A = -55^{\circ}C$ to $\pm 125^{\circ}C$ , $V_{CC} = 5V \pm 10\%$ , unless otherwise noted

# READ CYCLE [1]

SYMBOL	PARAMETER	M2114AL-3		M2114A-4/L-4		M2114A-5		
		Min.	Max.	Min.	Max.	Min.	Max.	UNIT
t <sub>RC</sub>	Read Cycle Time	150		200		250		ns
t <sub>A</sub>	Access Time		150	ļ	200		250	ns
tco	Chip Selection to Output Valid		70		70		85	ns
t <sub>CX</sub>	Chip Selection to Output Active	10		10		10		ns
toro	Output 3-state from Deselection		40		50		60	ns
toha	Output Hold from Address Change	15		15		15		ns

# WRITE CYCLE [2]

SYMBOL	PARAMETER	M2114AL-3		M2114A-4/L-4		M2114A-5		
		Min.	Max.	Min.	Max.	Min.	Max.	UNIT
twc	Write Cycle Time	150	•	200		250	·	ns
tw	Write Time	90		120		135		ns
twa	Write Release Time	0		0		0		ns
totw	Output 3-state from Write		40		50	]	60	ns
tow	Data to Write Time Overlap	90		120		135		ns
t <sub>DH</sub>	Data Hold from Write Time	0		0		0		ns

### NOTES

- 1 A Read occurs during the overlap of a low  $\overrightarrow{\text{CS}}$  and a high  $\overline{\text{WE}}.$
- 2 A Write occurs during the overlap of a low  $\overline{\text{CS}}$  and a low  $\overline{\text{WE}}$  twis measured from the latter of  $\overline{\text{CS}}$  or  $\overline{\text{WE}}$  going low to the earlier of  $\overline{\text{CS}}$  or WE going high

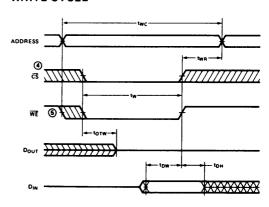
# **WAVEFORMS READ CYCLE**<sup>3</sup>

# Dout

#### NOTES

- 3 WE is high for a Read Cycle
- 4 If the CS low transition occurs simultaneously with the WE low transition, the output buffers remain in a high impedance
- 5 WE must be high during all address transitions

# **WRITE CYCLE**



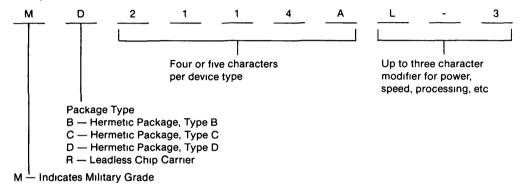
# ORDERING INFORMATION

#### **Status Notices**

PRELIMINARY—Indicates some electrical parameters are subject to change ADVANCE INFORMATION—Indicates some functional characteristics are subject to change

Semiconductor components are identified as follows

#### Example



For Military products, MIL-STD-883 Class B processing is indicated by a /B suffix, all others should be specified by the "s" number suffix

### Examples

MD2147H/B 4K x 1 Static RAM

4K x 1 Static RAM, hermetic package Type D, military temperature range, MIL-STD-883

Class B processing

MD8080A/B 8080A microprocessor, hermetic package Type D, military temperature range, MIL-

STD-883 Class B processing

The latest Intel OEM price book should be consulted for availability of various options. These may be obtained from your local Intel representative or by writing directly to Intel Corporation, 3065 Bowers Avenue, Santa Clara, California 95051